

FQA9N90-F109

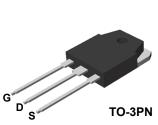
N-Channel QFET[®] MOSFET 900 V, 8.6 A, 1.3 Ω

Features

- + 8.6 A, 900 V, $R_{DS(on)}$ = 1.3 Ω (Max.) @ V_{GS} = 10 V, I_D = 4.3 A
- Low Gate Charge (Typ. 55 nC)
- Low Crss (Typ. 25 pF)
- 100% Avalanche Tested
- RoHS Compliant

Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.



Absolute Maximum Ratings $T_{C} = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter Drain-Source Voltage		FQA9N90-F109	Unit V	
V _{DSS}			900		
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)		8.6	А	
	- Continuous (T _C = 100°C)		5.45	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	34.4	А	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	900	mJ	
I _{AR}	Avalanche Current	(Note 1)	8.6	А	
E _{AR}	Repetitive Avalanche Energy (Note 1		24	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.0	V/ns	
P _D	Power Dissipation (T _C = 25°C)		240	W	
	- Derate Above 25°C		1.92	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FQA9N90-F109	Unit	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case, Max.	0.52	°C/W	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.24	°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient, Max.	40	°C/W	

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Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQA9N90-F109	FQA9N90	TO-3PN	Tube	N/A	N/A	50 units

Electrical Characteristics $T_{C} = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics				1	
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I _D = 250 μ A	900			V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		1.0		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 900 V, V _{GS} = 0 V			10	μA
		V _{DS} = 720 V, T _C = 125°C			100	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30 V, V_{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V			-100	nA
On Charac	teristics					
V _{GS(th)}	Gate Threshold Voltage	V_{DS} = V_{GS} , I_D = 250 μ A	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 4.3 A		1.0	1.3	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 4.3 A		9.2		S
Dynamic C	haracteristics					
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,		2100	2700	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		200	260	pF
C _{rss}	Reverse Transfer Capacitance	_		25	33	pF
Switching	Characteristics			-j		
t _{d(on)}	Turn-On Delay Time	V _{DD} = 450 V, I _D = 8.6 A,		45	100	ns
t _r	Turn-On Rise Time	R _G = 25 Ω (Note 4)		100	210	ns
t _{d(off)}	Turn-Off Delay Time			135	280	ns
t _f	Turn-Off Fall Time			80	170	ns
Qg	Total Gate Charge	V _{DS} = 720 V, I _D = 8.6 A, V _{GS} = 10 V		55	72	nC
Q _{gs}	Gate-Source Charge			12		nC
Q _{gd}	Gate-Drain Charge	(Note 4)		26		nC
Drain-Sour	ce Diode Characteristics and Maximum Rat	ings		1		1
I _S	Maximum Continuous Drain-Source Diode Forward Current				8.6	А
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				34.4	А
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 8.6 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 8.6 A,		720		ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/μs		7.6		μC

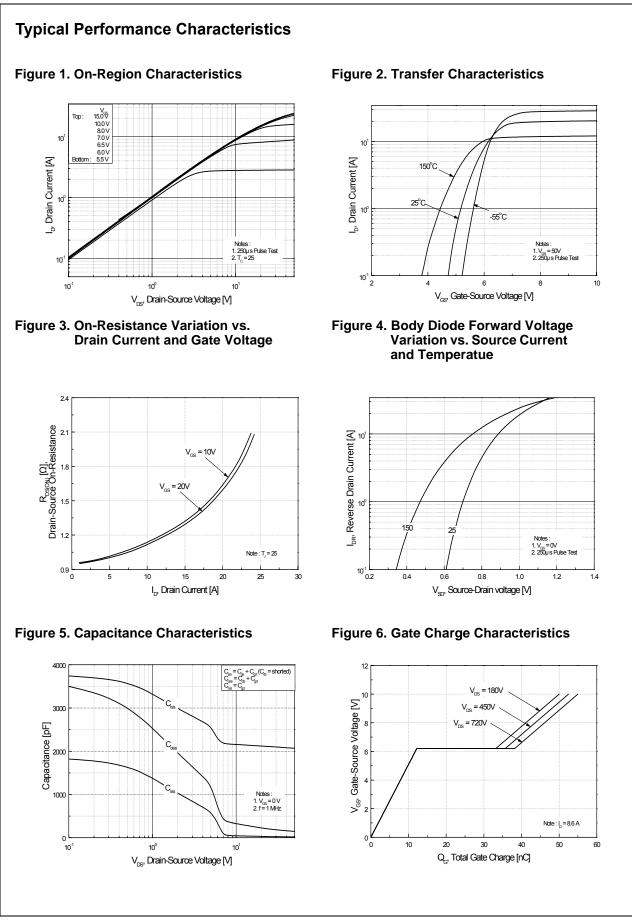
NOTES:

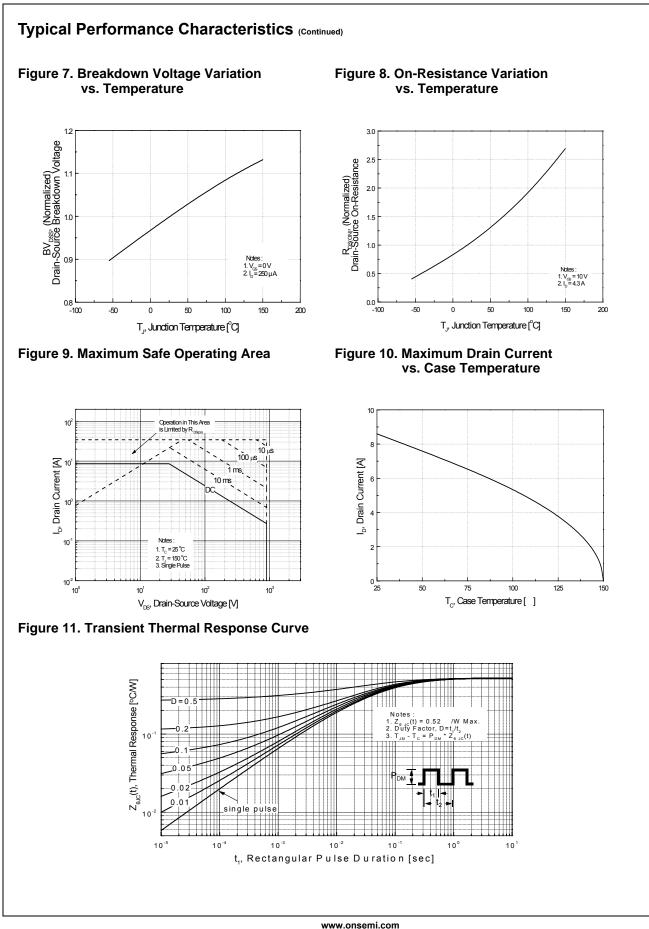
1. Repetitive rating : pulse-width limited by maximum junction temperature.

2. L = 23 mH, I_{AS} = 8.6 A, V_{DD} = 50 V, R_G = 25 $\Omega,$ starting $\mbox{ T}_{J}$ = 25°C.

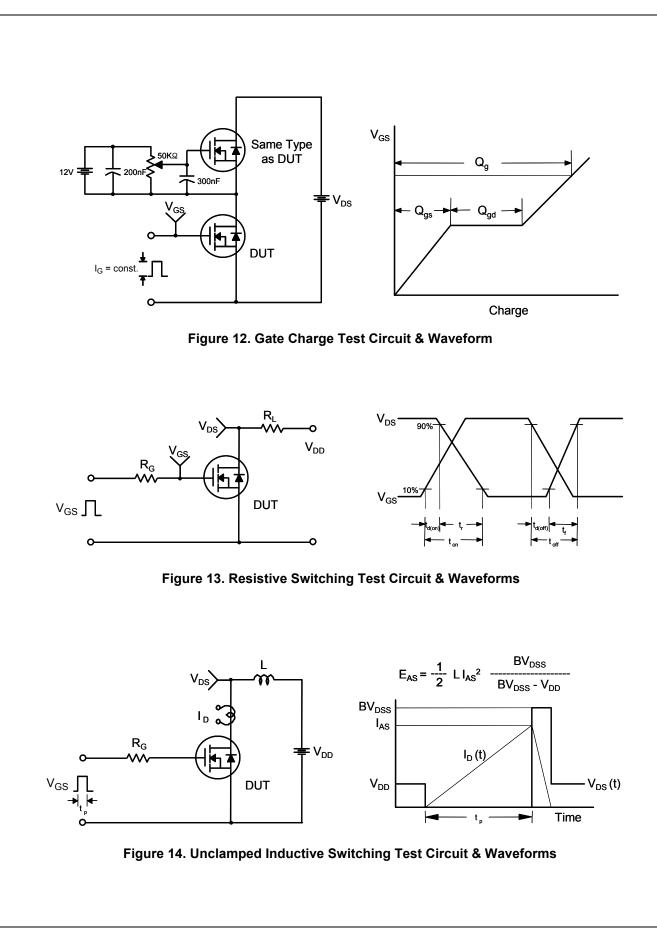
3. I_{SD} \leq 8.6 A, di/dt \leq 200 A/µs, V_{DD} \leq BV_{DSS,} starting ~T_J = 25°C.

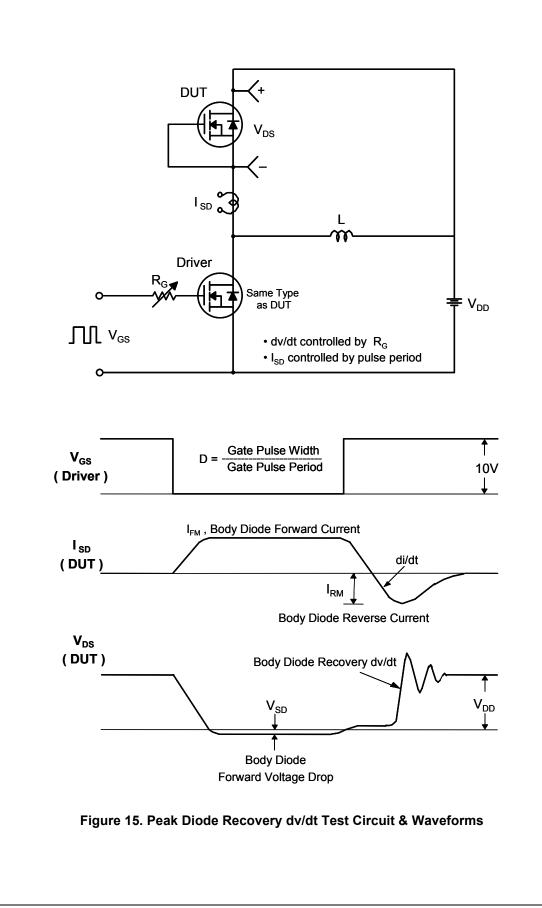
4. Essentially independent of operating temperature.





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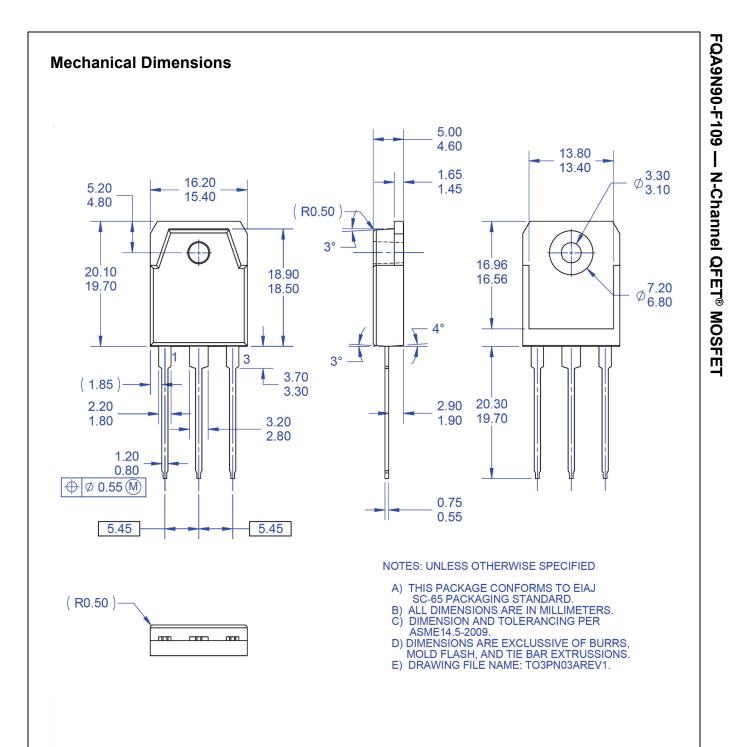


Figure 16. TO3PN, 3-Lead, Plastic, EIAJ SC-65

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